Karlsruhe Institute of Technology



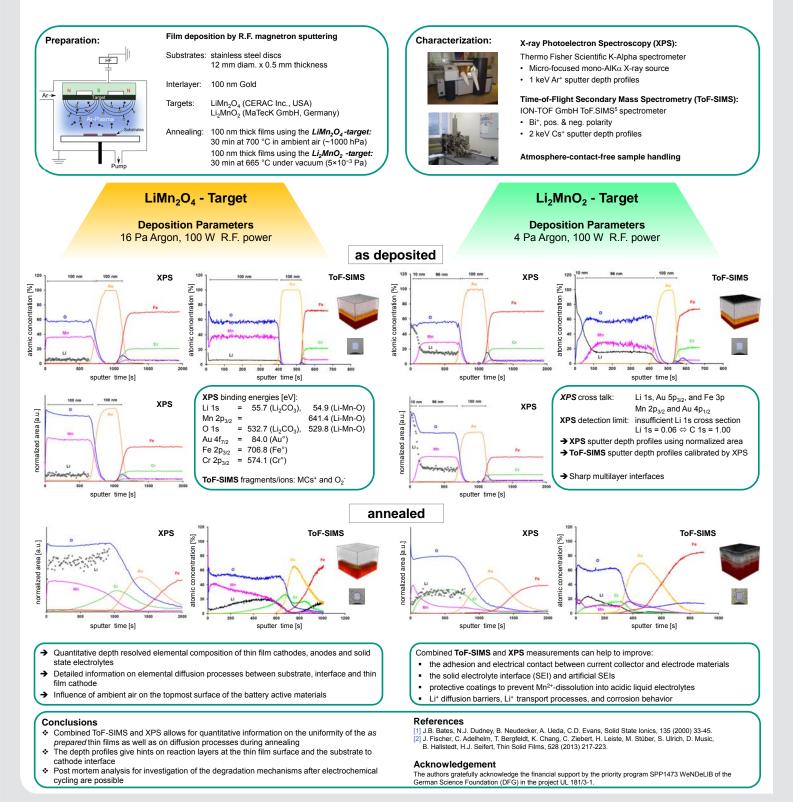
² Karlsruhe Nano Micro Facility (KNMF) Hermann-von-Helmholtz-Platz 1 76344 Eggenstein-Leopoldshafen, Germany.

*Corresponding author: michael.bruns@kit.edu

ToF-SIMS and XPS Characterization of R.F. Magnetron Sputtered Li-Mn-O Thin Films for Li-Ion Batteries

M. Bruns^{1,2,*}, J. Fischer¹, H. Ehrenberg¹, H.J. Seifert¹, S. Ulrich¹

Most of currently available lithium-ion batteries operate with toxic and highly flammable liquid electrolytes bearing risks of leakage, ignitability and undesirable side-reactions. To overcome these problems a very promising approach is the development of all-solid-state-LIBs by means of thin-film technology. Such batteries consist of a solid multilayer stack of cathode, electrolyte and anode thin films of about 3 µm overall thickness [1]. The present study focusses on the surface analytical characterization of environmental friendly Li-Mn-O based thin film cathodes fabricated by means of combined R.F. magnetron sputtering and furnace annealing [2]. ToF-SIMS and XPS allows for quantitative information on the uniformity of the as prepared thin films as well as of the atomic and/or ionic inter-diffusion of the layer constituents at the contact interface (cathode and current collector) during annealing. Special care was taken to widely guarantee atmosphere-contact-free sample transport.



KIT – University of the State of Baden-Wuerttemberg and National Research Center of the Helmholtz Association

www.kit.edu